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## CORRECTION

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## Correction: Triple cation additive $NH_3^+C_2H_4NH_2^+C_2H_4NH_3^+$ -induced phase-stable inorganic $\alpha$ -CsPbI<sub>3</sub> perovskite films for use in solar cells

Xihong Ding,<sup>a</sup> Haibin Chen,<sup>a</sup> Yahan Wu,<sup>a</sup> Shuang Ma,<sup>a</sup> Songyuan Dai,\*<sup>ab</sup> Shangfeng Yang<sup>c</sup> and Jun Zhu\*<sup>d</sup>

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Correction for 'Triple cation additive  $NH_3^+C_2H_4NH_2^+C_2H_4NH_3^+$ -induced phase-stable inorganic  $\alpha$ -CsPbI $_3$  perovskite films for use in solar cells' by Xihong Ding et al., J. Mater. Chem. A, 2018, **6**, 18258–18266, DOI: 10.1039/C8TA04590A.

The authors apologise that there are errors with the XRD data originally presented in Fig. 4e and Fig. S3a. After carefully reviewing our original data, we found that the XRD spectrum of CsPbI<sub>3</sub>·0.05DETAI<sub>3</sub> films aged for 48 h at 80 °C in Fig. 4e and the XRD spectrum of CsPbI<sub>3</sub>·0.05EDAI<sub>2</sub> aged for 60 days in Fig. S3a are incorrect due to the confusion of labels of samples. The error has no effect on the discussion and main conclusion. The correct figures are provided herein.

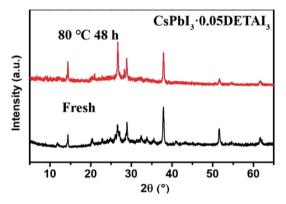


Fig. 4e XRD pattern of fresh CsPbI<sub>3</sub>·0.05DETAI<sub>3</sub> and CsPbI<sub>3</sub>·0.05DETAI<sub>3</sub> aged at 80 °C for 48 h.

<sup>&</sup>quot;Beijing Key Laboratory of Novel Thin-Film Solar Cells, Beijing Key Laboratory of Energy Safety and Clean Utilization, North China Electric Power University, Beijing 102206, China. E-mail: sydai@ncepu.edu.cn

bKey Laboratory of Photovoltaic and Energy Conservation Materials, Hefei Institutes of Physical Science, Chinese Academy of Sciences, Hefei 230031, China

Department of Materials Science and Engineering, University of Science and Technology of China, Hefei 230026, China

<sup>&</sup>lt;sup>4</sup>National Engineering Lab of Special Display Technology, State Key Lab of Advanced Display Technology, Academy of Opto-Electronic Technology, Hefei University of Technology, Hefei, 230009, China. E-mail: jzhu@hfut.edu.cn

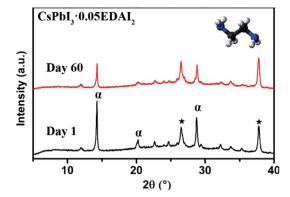


Fig. S3a XRD patterns of  $CsPbI_3 \cdot 0.05EDAI_2$  films of day 1 and day 60 stored in a dark dry box, inset image is the structure of ethylenediamine.

The Royal Society of Chemistry apologises for these errors and any consequent inconvenience to authors and readers.